Trench Power MOSFET

-20 V, Single P-Channel, SOT-23

Features

- Leading –20 V Trench for Low R_{DS(on)}
- -1.8 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint
- NTRV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Load/Power Management for Portables
- Load/Power Management for Computing
- Charging Circuits and Battery Protection

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	-20	V
Gate-to-Source Voltage			V _{GS}	±8.0	V
Continuous Drain	Steady	, ,,		-2.4	Α
Current (Note 1)	State	T _A = 85°C		-1.7	
	t ≤ 10 s	T _A = 25°C		-3.2	
Power Dissipation (Note 1)	Steady T _A = 25°		P _D	0.73	W
	t ≤ 10 s			1.25	
Continuous Drain	Steady	T _A = 25°C	I _D	-1.8	Α
Current (Note 2)	State	T _A = 85°C		-1.3	
Power Dissipation (Note 2)		T _A = 25°C	P _D	0.42	W
Pulsed Drain Current	tp =	: 10 μs	I _{DM}	-18	Α
ESD Capability (Note 3)	pability (Note 3) $C = 100 \text{ pF},$ RS = 1500 Ω			225	V
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C
Source Current (Body Dio	I _S	-2.4	Α		
Single Pulse Drain–to–Source Avalanche Energy (V_{GS} = -8 V, I_{L} = -1.8 Apk, L = 10 mH, R_{G} = 25 Ω)			EAS	16	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

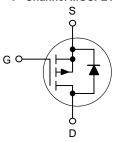


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX
–20 V	70 mΩ @ –4.5 V	
	90 mΩ @ –2.5 V	–3.2 A
	112 mΩ @ –1.8 V	

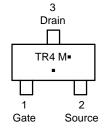
P-Channel MOSFET



MARKING DIAGRAM & PIN ASSIGNMENT



SOT-23 CASE 318 STYLE 21



TR4 = Device Code M = Date Code ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTR4101PT1G	SOT-23	3000 / Tape &
NTRV4101PT1G	(Pb-Free)	Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)		100	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	300	

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. ESD Rating Information: HBM Class 0

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 4) $(V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A})$			-20			V
Zero Gate Voltage Drain Current (Note 4) (V _{GS} = 0 V, V _{DS} = -16 V)					-1.0	μΑ
Gate-to-Source Leakage Current (V _{GS} = ±8.0 V, V _{DS} = 0 V)					±100	nA
ON CHARACTERISTICS						•
Gate Threshold Voltage (Note 4) $(V_{GS} = V_{DS}, I_D = -250 \mu A)$		V _{GS(th)}	-0.4	-0.72	-1.2	V
Drain-to-Source On-Resistance $(V_{GS} = -4.5 \text{ V}, I_D = -1.6 \text{ A})$ $(V_{GS} = -2.5 \text{ V}, I_D = -1.3 \text{ A})$ $(V_{GS} = -1.8 \text{ V}, I_D = -0.9 \text{ A})$				70 90 112	85 120 210	mΩ
Forward Transconductance (V _{DS} = -5.0 V, I _D = -2.3 A)				7.5		S
CHARGES, CAPACITANCES & GA	TE RESISTANCE					
Input Capacitance		C _{iss}		675		pF
Output Capacitance	$(V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = -10 \text{ V})$	C _{oss}		100		-
Reverse Transfer Capacitance		C _{rss}		75		
Total Gate Charge	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q _{G(tot)}		7.5	8.5	nC
Gate-to-Source Gate Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q_{GS}		1.2		nC
Gate-to-Drain "Miller" Charge	$(V_{DS} = -10 \text{ V}, I_D = -1.6 \text{ A})$	Q_{GD}		2.2		nC
Gate Resistance		R_{G}		6.5		Ω
SWITCHING CHARACTERISTICS	(Note 5)					
Turn-On Delay Time		t _{d(on)}		7.5		ns
Rise Time	$(V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$	t _r		12.6		
Turn-Off Delay Time	$I_D = -1.6 \text{ A}, R_G = 6.0 \Omega$	t _{d(off)}		30.2		
Fall Time		t _f		21.0		
DRAIN-SOURCE DIODE CHARAC	TERISTICS					
Forward Diode Voltage	$(V_{GS} = 0 \text{ V}, I_{S} = -2.4 \text{ A})$	V _{SD}		-0.82	-1.2	V
Reverse Recovery Time		t _{rr}		12.8	15	ns
Charge Time	$(V_{GS} = 0 \text{ V},$ $dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, I_{S} = -1.6 \text{ A})$	ta		9.9		ns
Discharge Time]	t _b		3.0		ns
Reverse Recovery Charge				1008		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 5. Switching characteristics are independent of operating junction temperature.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

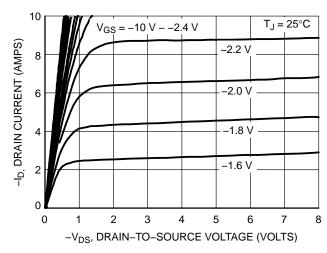


Figure 1. On-Region Characteristics

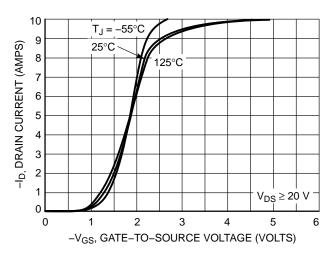


Figure 2. Transfer Characteristics

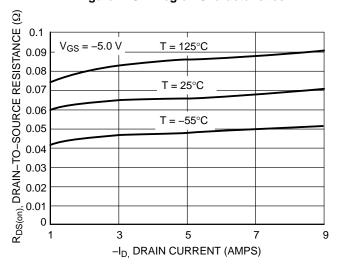


Figure 3. On–Resistance vs. Drain Current and Temperature

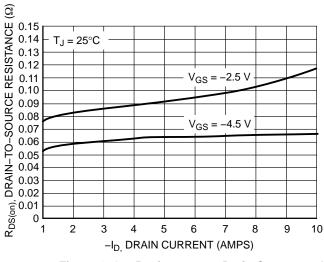


Figure 4. On–Resistance vs. Drain Current and Temperature

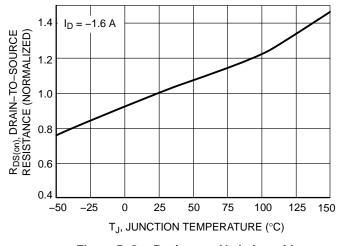


Figure 5. On–Resistance Variation with Temperature

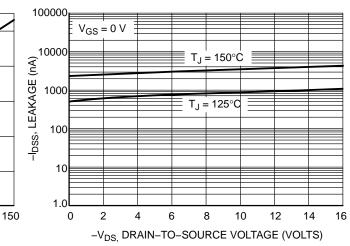


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES ($T_J = 25^{\circ}C$ unless otherwise noted)

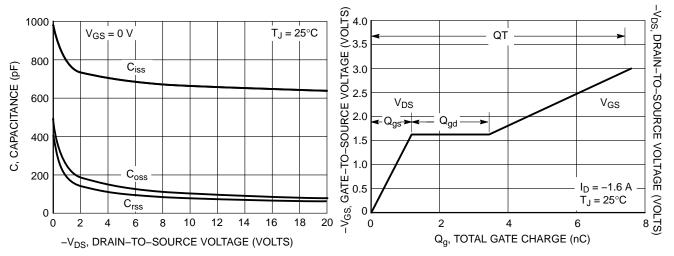


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Gate Charge

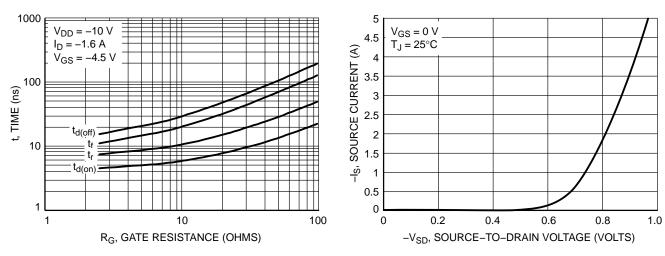


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

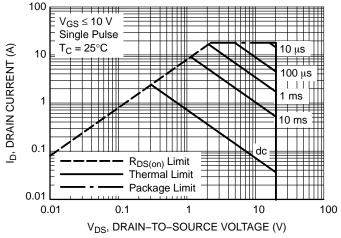
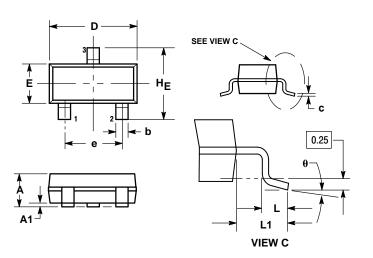


Figure 11. Maximum Rated Forward Biased Safe Operating Area

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AP**



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1. DII 1982.
- 2. CONTROLLING DIMENSION: INCH.
 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,

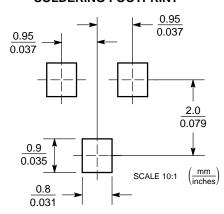
PRO	RUSION PLOMETERS URKS.				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.89	1.00	1.11	0.035	0.040	0.044	
A1	0.01	0.06	0.10	0.001	0.002	0.004	
b	0.37	0.44	0.50	0.015	0.018	0.020	
С	0.09	0.13	0.18	0.003	0.005	0.007	
D	2.80	2.90	3.04	0.110	0.114	0.120	
E	1.20	1.30	1.40	0.047	0.051	0.055	
е	1.78	1.90	2.04	0.070	0.075	0.081	
L	0.10	0.20	0.30	0.004	0.008	0.012	
L1	0.35	0.54	0.69	0.014	0.021	0.029	
HE	2.10	2.40	2.64	0.083	0.094	0.104	
θ	0°		10°	0°		10°	

STYLE 12:

PIN 1. CATHODE 2. CATHODE

- 3. ANODE

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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